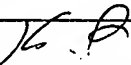


**Notice of References Cited**

Application/Control No.

10/550,445

Applicant(s)/Patent Under  
Reexamination  
OOTA ET AL.Examiner 

Kamran Afshar, 571-272-7796

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Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,269,256	07-2001	Nakamura, Taisuke	455/575.3
*	B	US-6,535,749	03-2003	Iwata et al.	455/556.2
*	C	US-6,254,249	07-2001	Kim et al.	455/550.1
*	D	US-6,839,101	01-2005	Shima, Makoto	349/58
*	E	US-2004/0072589	04-2004	Hamamura et al.	455/550.1
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002232534 A	08-2002	Japan	YOSHIDA et al.	H04M001/02
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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